

Model: XD-150

Analytical Probe Station

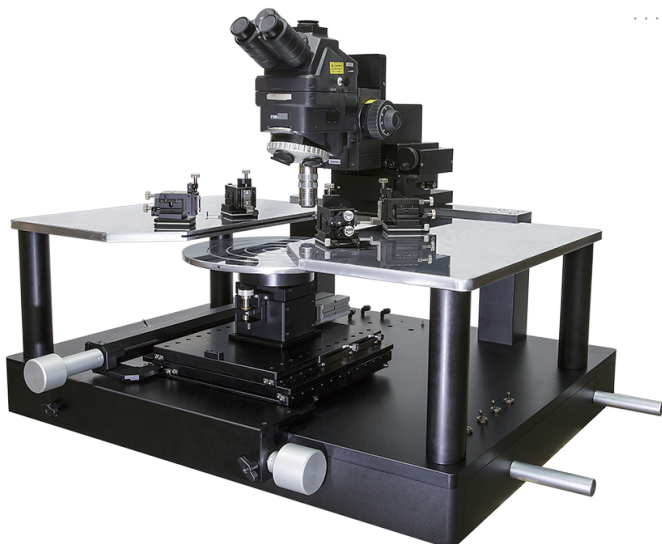
» The Probe Station XD-150 is a dedicated probing solution that comes with everything you need to achieve accurate measurement results in the shortest time, with maximum confidence. The system Provides best known methods for I-V/C-V measurements.

Designed for upgradability and extendable with multiple options. The Probe Station XD-150 can be easily reconfigured to meet your future project requirements, such as high voltage testing.



» Specifications

Vacuum Chuck 6"
Hugd-Knob Chuck Stage
Chuck stage 6"x6" Travel
Chuck Theta 0°~30°
Chuck Up/Down 4mm Adjustable
Microscope Stage 2"x2" Travel
Platen Up/Down 6mm Adjustable/Coarse Adjustment/Lever-Driven
Platen Up/Down 25mm Adjustable/Fine Adjustment/Hand wheel-Driven
580mmW x 460mmD x 700mmH With Microscope
Weight 60kg with microscope



» Accessories

Microscope Magnification : 1000X
Hot Chuck : 200/300/400°C
Special Chuck Design for RF
CCD and Screen
Micropositioner
Tip Holder
Shielding Box
Vibration Free Table